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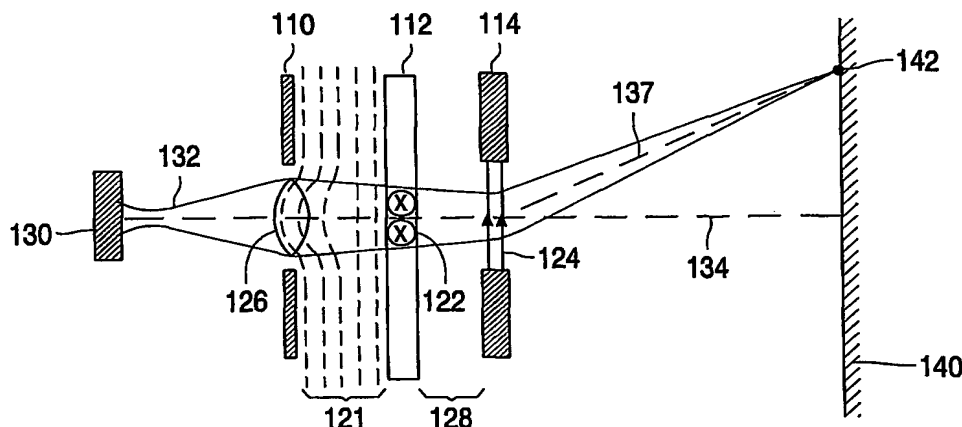
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- (71) Applicant (for all designated States except US): **KONINKLIJKE PHILIPS ELECTRONICS N.V.** [NL/NL]; Groenewoudseweg 1, NL-5621 BA Eindhoven (NL).
- (72) Inventors; and
- (75) Inventors/Applicants (for US only): **VISSENBERG, Michel, C., J., M.** [NL/NL]; c/o Prof. Holstlaan 6, NL-5656 AA Eindhoven (NL). **VAN ABELEN, Frank, A.** [NL/NL]; c/o Prof. Holstlaan 6, NL-5656 AA Eindhoven (NL). **CORTENRAAD, Hubertus, M., R.** [NL/NL]; c/o Prof. Holstlaan 6, NL-5656 AA Eindhoven (NL). **HOLTSLAG, Antonius, H., M.** [NL/NL]; c/o Prof. Holstlaan 6, NL-5656 AA Eindhoven (NL).
- (74) Agent: **ROLFES, Johannes, G., A.**; Prof. Holstlaan 6, NL-5656 AA Eindhoven (NL).
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(54) Title: ELECTROSTATIC DEFLECTION SYSTEM AND DISPLAY DEVICE



(57) Abstract: The invention relates to an electrostatic deflection system for deflecting an electron beam (132), and to a matrix display device provided with such an electrostatic deflection system. The deflection system has deflectors (112, 114) for the horizontal and vertical directions, and a focus electrode (110). By applying a sufficiently high voltage difference of for example several kiloVolts between the focus electrode (110) and at least one of the deflectors (112, 114), a bipotential type focusing electron lens is integrated with the deflection system. Thereby, the system achieves simultaneous deflection of the electron beam (132) and focusing of the electron beam onto a surface (140) to be scanned. In a matrix display device, the electron beam (132) may be kept in focus on the display screen (134) thereby obtaining a relatively small spot size and high image quality. Generally, the display screens divided into a number of portions (134). In operation, each portion is scanned by a separate electron beam (132).



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